

# Final Product/Process Change Notification Document #: FPCN20904X Issue Date: 27 May 2015

Title of Change:	Addition of ASE Shanghai, China as qualified assembly site for QFN devices.		
Proposed first ship date:	3 September 2015		
Contact information:	Contact your local ON Semiconductor Sales Office or Norhayati Othman <norhayati.othman@onsemi.com></norhayati.othman@onsemi.com>		
Samples:	Contact your local ON Semiconductor Sales Office		
Additional Reliability Data:	Contact your local ON Semiconductor Sales Office or Chean Ching Sim <cheanching.sim@onsemi.com></cheanching.sim@onsemi.com>		
Type of notification:	This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 90 days prior to implementation of the change.  ON Semiconductor will consider this change approved unless specific conditions of acceptance are provided in writing within 30 days of receipt of this notice. To do so, contact <pcn.support@onsemi.com>.</pcn.support@onsemi.com>		
Change Part Identification:	Marking of the month date codes:		
	Seremban Malaysia assembled devices: M  ASE Shanghai assembled devices:		
Change category(s):  ☐ Wafer Fab Change ☐ Assembly Change ☐ Test Change	☐ Manufacturing Site Change/Addition ☐ Manufacturing Process Change ☐ Material Change	☐ Product specific change ☐ Datasheet/Product Doc change ☐ Shipping/Packaging/Marking ☐ Other:	
Sites Affected:  ☐ All site(s) ☐ not applicable ☐ ON Semiconductor site(s): ☐ External Foundry/Subcon site		Site 2	
	•		
Description and Purpose:		<u></u>	
This is the final notification anno this notification (please refer to	ouncing that ON Semiconductor is qualifying an addi	tional assembly site for the list of QFN products included in complete device list). The additional assembly site is the I has already been qualified and utilized by ON	
This is the final notification anno this notification (please refer to ASE Shanghai factory located in C Semiconductor.  Two devices have been identified	ouncing that ON Semiconductor is qualifying an addi the "List of Affected Standard Parts" section for the China. This facility is ISO/TS16949:2009 certified and	complete device list). The additional assembly site is the last already been qualified and utilized by ON mension, die size and volumes. Full electrical characterization	
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## Final Product/Process Change Notification

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#### **Reliability Data Summary:**

Package: UDFN10

Qual Vehicle: ESD8004MUTAG

**Qualification Results and Analysis:** 

Test Conditions Interval Results

HTRB TA=150C, 80% Rated Voltage 1008 hrs 0/672 SAT NA NA Pass

Conclusion: All reliability requirements have been met.

Package: UDFN10

Qual Vehicle: ESD8104MUTAG

**Qualification Results and Analysis:** 

Test Conditions Interval Results

 HTRB
 TA=150C, 80% Rated Voltage
 1008 hrs
 0/672

 SAT
 NA
 NA
 Pass

Conclusion: All reliability requirements have been met.

### **Electrical Characteristic Summary:**

No changes in electrical specifications; all product performance meets current datasheet specifications.

#### **List of affected Standard Parts:**

Device	SBN	ASE
ESD8004MUTAG	E	N
ESD8104MUTAG	E	N
ESD8006MUTAG	E	N
ESD8008MUTAG	E	N
ESD8004TMUTAG	E	N
ESD8040MUTAG	E	N
ESD8106MUTAG	E	N
ESD7504MUTAG	E	N
ESD7408MUTAG	E	N

Note: E – Existing Assembly Site N – New Assembly Site

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